DISPLAY Elektronik GmbH

DATA SHEET

TFT MODULE

DEM 376960A VMH-PW-N

2,9" TFT

Product Specification Ver.: 0

11.09.2023

REVIS	SION HISTORY:			
Rev	Date	Description	Written By WYC	Approved By LSB
0	11.09.2023	New release.	WYC	LSB

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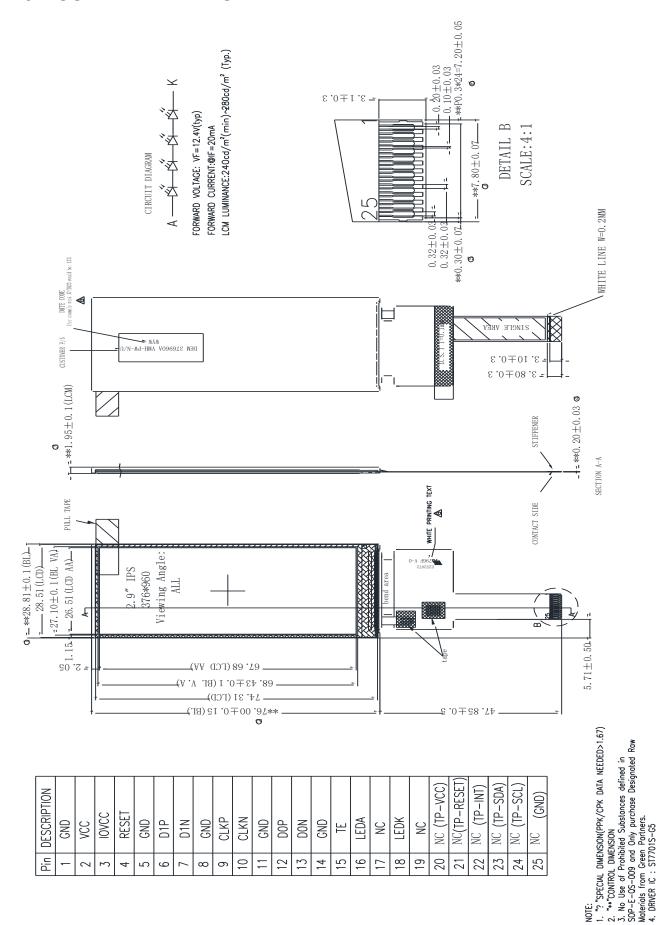
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1.0 GENERAL SPECIFICATION

Item	Contents	Unit
Display Mode	2.9" TFT Transmissive/IPS/Normally Black	-
Module outer dimension	28.81 x 76.0 x 1.95 (Excluded FPC length)	mm
Pixel Size	0.135×0.135	mm
Effective display area	26.51 x 67.68	mm
Number of dots	376 x RGB × 960	dots
Viewing direction	Free	O'clock
Pixel Arrangement	RGB Vertical Stripe	-
Backlight	LED white backlight	-
Driver IC	ST7701S-G5	-
Interface type	4 line SPI	-
Number Of Colors	262K	-
Operating temperature	-20 ~ 70	°C
Storage temperature	-30 ~ 80	°C

Remarks: Normal operating condition is temperature 15~35°C, humidity 45%~75%RH, atmospheric pressure 86~106kPa.

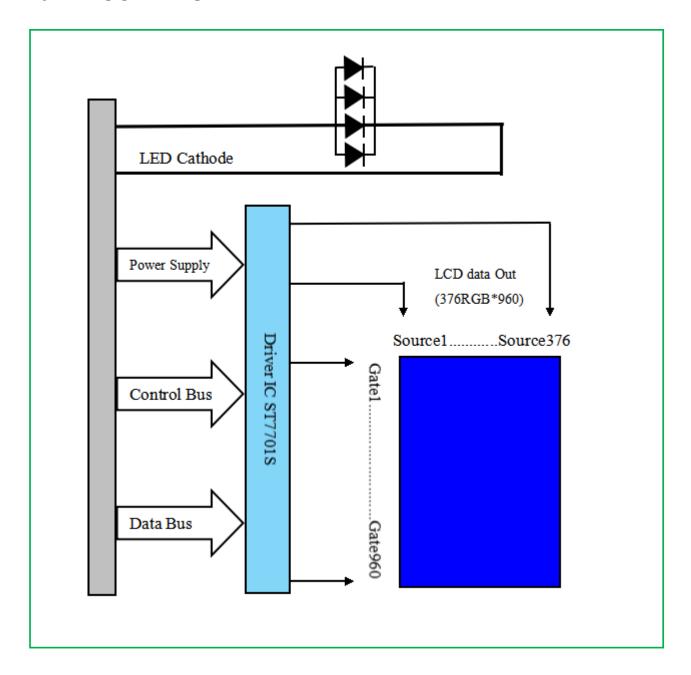
2.0 OUTLINE DRAWING



3.0 INTERFACE PIN DESCRIPTION

Pin No.	Symbol	Pin Description
1	GND	Ground
2	VCC	Power supply voltage
3	IOVCC	Power supply for the logic power and I/O circuit
4	RESET	Reset Signal Input Pin
5	GND	Ground
6	D1P	MIPI DSI data1+
7	D1N	MIPI DSI data1-
8	GND	Ground
9	CLKP	MIPI DSI clock+
10	CLKN	MIPI DSI clock-
11	GND	Ground
12	D0P	MIPI DSI data0+
13	D0N	MIPI DSI data1+
14	GND	Ground
15	TE	Tearing Effect pin.
16	LEDA	LED backlight anode.
17	NC	No connection.
18	LEDK	LED backlight cathode.
19	NC	No connection.
20	NC(TP-VCC)	No connection.
21	NC(TP-RESET)	No connection.
22	NC(TP-INT)	No connection.
23	NC(TP-SDA)	No connection.
24	NC(TP-SCL)	No connection.
25	NC(GND)	No connection.

4.0 BLOCK DIAGRAM



5.0 OPERATING PRINCIPLE & DRIVING METHOD

- 5.1 Please refer to ST7701SN-1 (Ver N1.0) IC data sheet.
- 5.2 Instruction Description (based on IC spec ver as stated in 6.1 where the product is designed). This instruction description is for reference only. Customer is encouraged to always refer to the latest IC specification when developing application system platform.

5.3 Recommended initial codes void LCD Init(void) // VBP=16:VFP=16: //Line time:16.7 WriteComm (0xFF); WriteData (0x77); WriteData (0x01); WriteData (0x00); WriteData (0x00); WriteData (0x13); WriteComm (0xEF); WriteData (0x08); WriteComm (0xFF); WriteData (0x77); WriteData (0x01): WriteData (0x00): WriteData (0x00): WriteData (0x10); WriteComm (0xC0); WriteData (0x77); WriteData (0x00); WriteComm (0xC1); WriteData (0x0C); WriteData (0x0C); WriteComm (0xC2); WriteData (0x07); WriteData (0x02); WriteComm (0xCC); WriteData (0x10); WriteComm (0xB0); WriteData (0x00); WriteData (0x0C); WriteData (0x19); WriteData (0x0B); WriteData (0x0F); WriteData (0x06): WriteData (0x05); WriteData (0x08); WriteData (0x08); WriteData (0x1F); WriteData (0x04); WriteData (0x11);

WriteData (0x0F);

```
WriteData (0x26);
WriteData (0x2F);
WriteData (0x1D);
WriteComm (0xB1);
WriteData (0x00);
WriteData (0x17);
WriteData (0x19);
WriteData (0x0F);
WriteData (0x12);
WriteData (0x05);
WriteData (0x05);
WriteData (0x08);
WriteData (0x07);
WriteData (0x1F);
WriteData (0x03);
WriteData (0x10);
WriteData (0x10);
WriteData (0x27);
WriteData (0x2F);
WriteData (0x1D);
WriteComm (0xFF);
WriteData (0x77);
WriteData (0x01);
WriteData (0x00);
WriteData (0x00);
WriteData (0x11);
WriteComm (0xB0);
WriteData (0x25);
WriteComm (0xB1);
WriteData (0x76);
WriteComm (0xB2);
WriteData (0x81);
WriteComm (0xB3);
WriteData (0x80);
WriteComm (0xB5);
WriteData (0x4E);
WriteComm (0xB7);
WriteData (0x85);
WriteComm (0xB8);
WriteData (0x20);
WriteComm (0xC1);
WriteData (0x78);
WriteComm (0xC2);
WriteData (0x78);
WriteComm (0xD0);
WriteData (0x88);
```

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```
WriteComm (0xE0);
WriteData (0x00);
WriteData (0x00);
WriteData (0x02);
WriteData (0x00);
WriteData (0x00);
WriteData (0x0C);
WriteComm (0xE1);
WriteData (0x02);
WriteData (0x8C);
WriteData (0x04);
WriteData (0x8C);
WriteData (0x01);
WriteData (0x8C);
WriteData (0x03);
WriteData (0x8C);
WriteData (0x00);
WriteData (0x44);
WriteData (0x44);
WriteComm (0xE2);
WriteData (0x03);
WriteData (0x03);
WriteData (0x03);
WriteData (0x03);
WriteData (0x00);
WriteData (0x00);
WriteData (0xD4);
WriteData (0x00);
WriteData (0x00);
WriteData (0x00);
WriteData (0xD4);
WriteData (0x00);
WriteComm (0xE3);
WriteData (0x00):
WriteData (0x00);
WriteData (0x33);
WriteData (0x33);
WriteComm (0xE4);
WriteData (0x44);
WriteData (0x44);
WriteComm (0xE5);
WriteData (0x09);
WriteData (0xD2);
WriteData (0x35);
WriteData (0x8C);
WriteData (0x0B);
WriteData (0xD4);
WriteData (0x35);
WriteData (0x8C);
WriteData (0x05):
WriteData (0xCE);
```

WriteData (0x35);

Version: 0

```
WriteData (0x8C);
WriteData (0x07);
WriteData (0xD0);
WriteData (0x35);
WriteData (0x8C);
WriteComm (0xE6);
WriteData (0x00);
WriteData (0x00);
WriteData (0x33);
WriteData (0x33);
WriteComm (0xE7);
WriteData (0x44);
WriteData (0x44);
WriteComm (0xE8);
WriteData (0x08);
WriteData (0xD1);
WriteData (0x35);
WriteData (0x8C);
WriteData (0x0A);
WriteData (0xD3);
WriteData (0x35);
WriteData (0x8C);
WriteData (0x04);
WriteData (0xCD);
WriteData (0x35);
WriteData (0x8C);
WriteData (0x06);
WriteData (0xCF);
WriteData (0x35);
WriteData (0x8C);
WriteComm (0xEB);
WriteData (0x00);
WriteData (0x01);
WriteData (0xE4):
WriteData (0xE4);
WriteData (0x44);
WriteData (0x00);
WriteComm (0xED);
WriteData (0x77);
WriteData (0x66);
WriteData (0x55);
WriteData (0x44);
WriteData (0xCA);
WriteData (0xF1);
WriteData (0x03);
WriteData (0xBF);
WriteData (0xFB);
WriteData (0x30);
WriteData (0x1F);
WriteData (0xAC);
WriteData (0x44):
WriteData (0x55);
WriteData (0x66);
```

Version: 0

```
WriteData (0x77);
WriteComm (0xEF);
WriteData (0x10);
WriteData (0x0D);
WriteData (0x04);
WriteData (0x08);
WriteData (0x3F);
WriteData (0x1F);
WriteComm (0xFF);
WriteData (0x77);
WriteData (0x01);
WriteData (0x00);
WriteData (0x00);
WriteData (0x13);
WriteComm (0xE8);
WriteData (0x00);
WriteData (0x0E);
WriteComm (0x11);
Delay_ms(120);
WriteComm (0xE8);
WriteData (0x00);
WriteData (0x0C);
Delay ms(20);
WriteComm (0xE8);
WriteData (0x00);
WriteData (0x00):
WriteComm (0xFF);
WriteData (0x77);
WriteData (0x01);
WriteData (0x00);
WriteData (0x00):
WriteData (0x00);
WriteComm (0x29);
WriteComm (0x35);
WriteData (0x00);//TE ON
WriteComm (0x36):
WriteData (0x00);//FW:00
                           BW:10
}
```

Notes:

- 1) These initial codes are only for reference, Customer should optimize above setting according to the display pattern and application used.
- 2) Customer is advised to refer to "General Handling Precaution of LCD Modules" section in this product specification regarding the operating precaution of LCD modules, when optimizing the display initialization setting.
- 3) Display Elektronik GmbH will use above initial code for production testing by default. Customer is advised to highlight to Display Elektronik GmbH in case that initial code setting in customer application is different with above initial code. Reason is to ensure Display Elektronik GmbH testing is in-line with customer application as close as possible for good quality control.

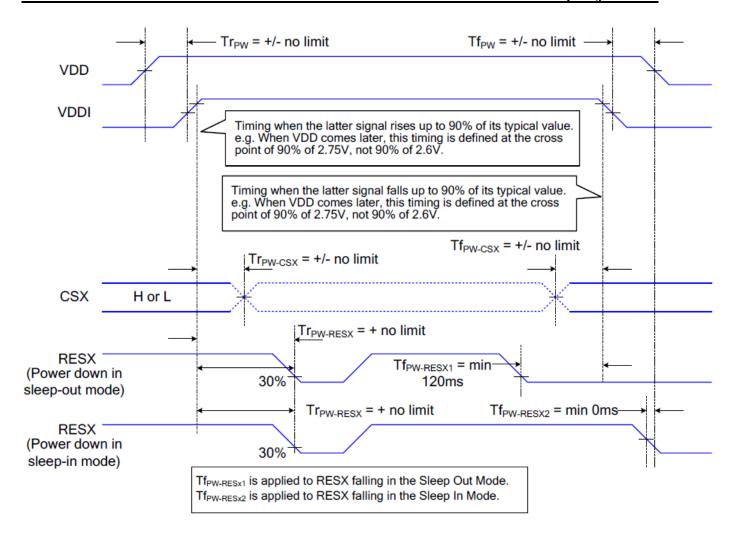
5.4 Power on/off sequence

VDDI and VDDA can be applied or powered down in any order. During the Power Off sequence, if the LCD is in the Sleep Out mode, VDDA and VDDI must be powered down with minimum 120msec. If the LCD is in the Sleep In mode, VDDA and VDDI can be powered down with minimum 0msec after the RESX is released.

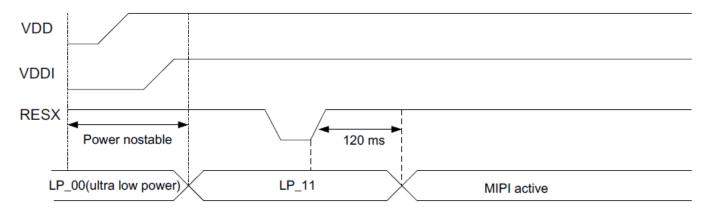
CSX can be applied at any timing or can be permanently grounded. RESX has high priority over CSX.

Notes:

- 1. There will be no damage to the ST7701SN-1 if the power sequences are not met.
- 2. There will be no abnormal visible effects on the display panel during the Power On/Off Sequences.
- 3. There will be no abnormal visible effects on the display between the end of Power On Sequence and before receiving the Sleep Out command, and also between receiving the Sleep In command and the Power Off Sequence.
- 4. If the RESX line is not steadily held by the host during the Power On Sequence as defined in Sections 9.1, then it will be necessary to apply the Hardware Reset (RESX) after the completion of the Host Power On Sequence to ensure correct operations. Otherwise, all the functions are not guaranteed.
- 5. When VDDA is in power off State, the MIPI must set in Ultra Low Power Mode (GND Level).
 The power on/off sequence is illustrated below



Note5:



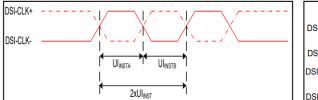
9.1 Uncontrolled Power Off

The uncontrolled power-off means a situation which removed a battery without the controlled power off sequence. It will neither damage the module or the host interface.

If uncontrolled power-off happened, the display will go blank and there will not any visible effect on the display (blank display) and remains blank until "Power On Sequence" powers it up.

5.5 Timing Characteristics

High Speed Mode



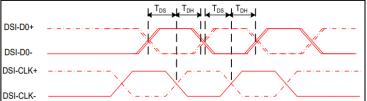


Figure 4 DSI clock channel timing

Figure 5 Rising and falling time on clock and data channel

VDDI=1.8,VDD=2.8, AGND=DGND=0V, Ta=25 ℃

Signal	Symbol	Parameter	MIN	MAX	Unit	Description
DSI-CLK+/-	2xUI _{INSTA}	Double UI instantaneous	2.5	25	ns	
DSI-CLK+/- Ulinsta		UI instantaneous halfs	1.25	12.5	ns	UI = UI _{INSTA} = UI _{INSTB}
DSI-Dn+/-	tDS	Data to clock setup time	0.15	-	UI	
DSI-Dn+/- tDH [Data to clock hold time	0.15	-	UI	

Table 7 Mipi Interface- High Speed Mode Timing Characteristics

Lowe Power Mode

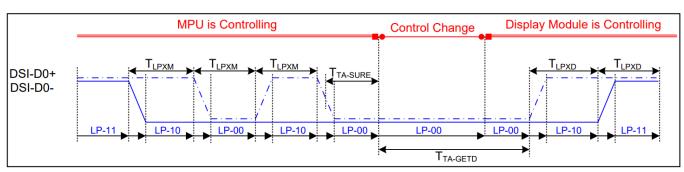


Figure 6 Bus Turnaround (BTA) from display module to MPU Timing

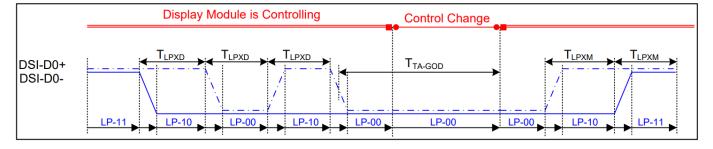


Figure 7 Bus Turnaround (BTA) from MPU to display module Timing

 $VDDI{=}1.8, VDD{=}2.8, AGND{=}DGND{=}0V, Ta{=}25~^{\circ}C$

Signal	Symbol	Parameter	MIN	MAX	Unit	Description	
		Length of LP-00,LP-01,					
DSI-D0+/-	TLPXM	LP-10 or LP-11 periods	50	75	ns	Input	
		MPU→Display Module					
		Length of LP-00,LP-01,				Output	
DSI-D0+/-	TLPXD	LP-10 or LP-11 periods	50	75	ns		
		MPU→Display Module					
DSI-D0+/-	TTA-SURED	Time-out before the MPU	T _{LPXD}	2xT _{LP}	ns	Output	
D3I-D0+/-		start driving	TLPXD	XD	115		
DSI-D0+/-	TTA-GETD	Time to drive LP-00 by	5xT _{LPXD}		20	Input	
D3I-D0+/-	TIA-GETD	display module			ns		
DSI-D0+/-	TTA-GOD	Time to drive LP-00 after	4vT	LPXD	nc	Output	
D3I-D0+/-	TIA-GOD	turnaround request-MPU	4 4 1	LPXD	ns		

Table 8 Mipi Interface Low Power Mode Timing Characteristics

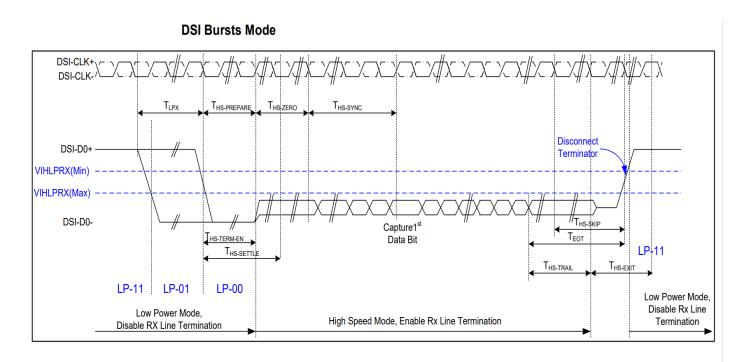


Figure 7 Data lanes-Low Power Mode to/from High Speed Mode Timing

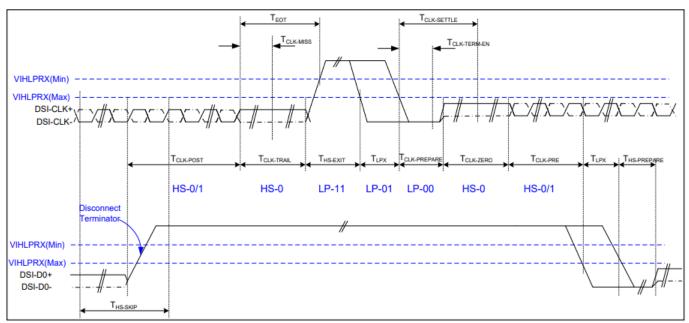


Figure 8 Clock lanes- High Speed Mode to/from Low Power Mode Timing

 $VDDI{=}1.8, VDD{=}2.8, AGND{=}DGND{=}0V, Ta{=}25~^{\circ}C$

Signal	Symbol	Parameter	MIN	MAX	Unit	Description		
Low Power Mode to High Speed Mode Timing								
DSI-Dn+/-	TLPX	Length of any low power state period	50	-	ns	Input		
DSI-Dn+/-	THS-PREPARE	Time to drive LP-00 to prepare	40+4	85+6	ns	Innut		
טויטוין-	THS-PREPARE	for HS transmission	UI	UI	115	Input		
DCI D /	THE TERM EN	Time to enable data receiver		35+4				
DSI-Dn+/-	THS-TERM-EN	line termination measured from when Dn crosses VILMAX	-	UI	ns	Input		
DCI Dn I	THS-PREPARE	THS-PREPARE + time to drive	140+			Input		
DSI-Dn+/-	+ THS-ZERO	HS-0 before the sync sequence	10UI	-	ns	Input		
		High Speed Mode to Low Power Mo	ode Timi	ng				
DCI Dm //	THE CKID	Time-out at display module to	40	55+4		Input		
DSI-Dn+/-	THS-SKIP	ignore transition period of EoT	40	UI	ns			
DSI-Dn+/-	THS-EXIT	Time to drive LP-11 after HS burst	100	-	ns	Input		
DSI-Dn+/-	THS-TRAIL	Time to drive flipped differential state after last payload data bit	60+4	- ns		Innut		
D31-D11+/-	THO-HVAIL	of a HS transmission burst	UI	-	115	Input		

High Speed Mode to/from Low Power Mode Timing							
DSI-CLK+/-	TCLK-POS	Time that the MPU shall continue sending HS clock after the last associated data lane has transition to LP mode 60+5		-	ns	Input	
DSI-CLK+/-	TCLK-TRAIL	Time to drive HS differential state after last payload clock bit of a HS transmission burst	60	-	ns	Input	
DSI-CLK+/-	THS-EXIT	Time to drive LP-11 after HS burst	100	-	ns	Input	
DSI-CLK+/-	TCLK-PREPARE	Time to drive LP-00 to prepare for HS transmission	38	95	ns	Input	
DSI-CLK+/-	TCLK-TERM-EN	Time-out at clock lan display module to enable HS transmission		38	ns	Input	
DSI-CLK+/-	TCLK-PREPARE + TCLK-ZERO	Minimum lead HS-0 drive period before starting clock	300	-	ns	Input	
DSI-CLK+/-	TCLK-PRE	Time that the HS clock shall be driven prior to any associated data lane beginning the transition from LP to HS mode	8UI	-	ns	Input	
DSI-CLK+/-	TEOT	Time form start of TCLK-TRAIL period to start of LP-11 state	-	105n s+12 UI	ns	Input	

7.5.5 Reset Timing:

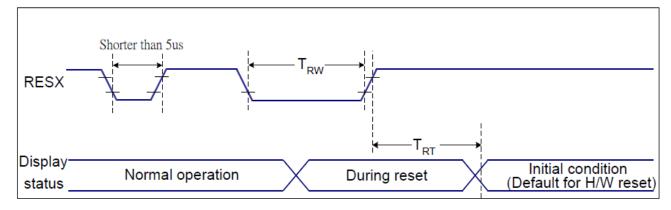


Figure 9 Reset Timing

VDDI=1.8,VDD=2.8, AGND=DGND=0V, Ta=25 $\,^{\circ}$ C

Related Pins	Symbol	Parameter	MIN	MAX	Unit
RESX	TRW	Reset pulse duration	Reset pulse duration 10 -		us
	TRT	Poset sensel	-	5 (Note 1, 5)	ms
		Reset cancel		120(Note 1, 6, 7)	ms

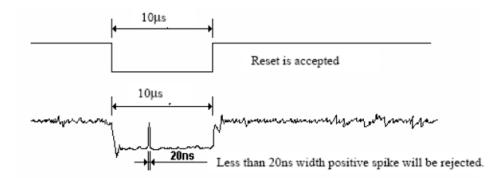
Table 9 Reset Timing

Notes:

- The reset cancel includes also required time for loading ID bytes, VCOM setting and other settings from NVM (or similar device) to registers. This loading is done every time when there is HW reset cancel time (tRT) within 5 ms after a rising edge of RESX.
 - Spike due to an electrostatic discharge on RESX line does not cause irregular system reset according to the table below:

RESX Pulse	Action
Shorter than 5us	Reset Rejected
Longer than 9us	Reset
Between 5us and 9us	Reset starts

- 3. During the Resetting period, the display will be blanked (The display is entering blanking sequence, which maximum time is 120 ms, when Reset Starts in Sleep Out –mode. The display remains the blank state in Sleep In –mode.) and then return to Default condition for Hardware Reset.
 - 4. Spike Rejection also applies during a valid reset pulse as shown below:



- 5. When Reset applied during Sleep In Mode.
- 6. When Reset applied during Sleep Out Mode.
- It is necessary to wait 5msec after releasing RESX before sending commands. Also Sleep Out command cannot be sent for
 120msec.

6.0 ABSOLUTE MAXIMUM RATINGS (Ta = 25°C, Vss = 0 V, Vcc=VDD, IOVCC=VDDI)

Parameter	Symbol	Min	Тур.	Max	Unit
System voltage	V_{DD}	-0.3	-	4.6	V
Interface Operation Voltage	VDDI	-0.3	-	4.6	
Driver supply voltage	VGH-VGL	-0.3	-	30	V
Input voltage	V_{IN}	-0.3	-	VDDI+0.3	V
Output voltage	Vo	-0.3	-	VDDI+0.3	V
Operating Temperature	Тор	-20	-	60	°C
Storage Temperature	Tst	-30	-	70	°C

7.0 ELECTRICAL CHARACTERISTICS(Ta = 25°C, Vss = 0 V, Vcc=Vdd)

Parameter	Symbol	Condition	Min	Тур.	Max	Unit
System voltage	V_{DD}	-	2.5	2.8	3.6	V
Interface Operation Voltage	VDDI	-	1.65	1.8	3.3	V
Gate on power	VGH	-	11.5	-	15	V
Gate off power	VGL	-	-10	-	-12	V
Vcom	Vcom	-	-	VSS	-	V
Logic high input voltage	V _{IH}	-	0.7VDDI	-	VDDI	V
Logic low input voltage	VIL	-	Vss	-	0.3VDDI	V
Logic high output voltage	V _{OH}	IOH=-1.0mA	0.8VDDI	-	VDDI	V
Logic low output voltage	V _{OL}	IOL= +1.0mA	Vss	-	0.2VDDI	V
LCM supply current	I _{LCM}	-	-	28	42	mA

8.0 ELECTRO-OPTICAL CHARACTERISTICS

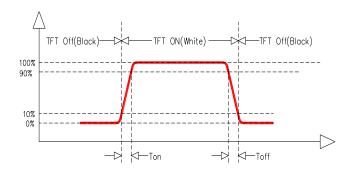
No	Item		Symbo I	Condi	tion	Min.	Тур.	Max.	Unit	Note
1	Response Tir	ne	T _{on} +T _{off}	$\theta = \phi =$	= 0°	-	30	40	ms	(a)
2	Contrast Rat	io	CR	$\theta = \phi =$	= 0°	1000	1250	-	-	(c)
			3:00	φ = 0)°	75	80	-	Deg	
3	Viewing Ang	le	9:00	φ = 18	30°	75	80	-	Deg	(h)
3	(CR ≥ 10)		12:00	φ = 9	0°	75	80	-	Deg	(b)
			6:00	φ = 27	70°	75 _{(b):}	Definition of V	iewing Angle	Deg	
4	Brightness on LCM	1	L _{LCM}	$ \theta = 0^{\circ} $	25°C	240	Normal († £0 j á		cd/m 2	(d)
		White	Wx		(ø=90° (12:00)	0.260	0.310	0.360	-	-
	Color	VVIIILE	Wy			0.275	0.325	0.375	(3.00)) -
	Chromaticity	Red	Rx		_	0.550	0.600	0.650	-	-
5	(CIE1931)	Red	Ry	θ=0°, φ=0)° [0.513	0.563	0.613	/ .	-
		Green	Gx	Ta=25°C	80°->	0.298	0.348	0.398	8	-
		Green	Gy	(9:00))	0.541	0.591	0.641	(ø=270°	-
		Pluo	Bx			0.085	0.135	0.185	(6400)	-
		Blue		_		0.027	0.077	0.127	-	-
6	NTSC			57.0%						

Remarks:

1) EOC data above is measured using DMS-501 display measurement system.

2) Brightness data is measured using photometer Topcon BM-7.

Note(a): Definition of Response Time



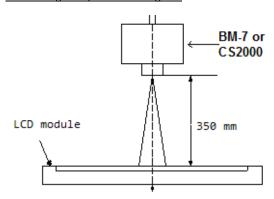
Note (c): Definition of Contrast Ratio

CR = Brightness at all pixels "White" / Brightness at all pixels "Black"

Note (d): backlight driving condition: If = 20mA

Luminance measuring point: Center of the dot matrix under white pattern

measuring setup as below figure:



9.0 BACKLIGHT SPECIFICATION

9.1 LED Backlight Electrical-optical characteristics

Item of backlight characteristics	Symbol	Min	Тур	Max	Unit	Condition
Forward voltage	Vf	11.6	12.4	13.2	V	1.If=20mA, T=25°C 2.Aperture:1°,5 Points
Uniformity	Δ	80	-	-	%	3.Average=min/max*100%
Number of LED	-	4 Pi			Piece	-
Connection mode	S/P/M	48			-	-
						1.Ta=25±5 °C, RH=60%±
						10%; If=20mA/LED
Life time	2.No other Life time luminous intensity attenuation to 50% at the beginning of the luminous intensity of time suddenly residue.					2.No other interference, Such as Current, Voltage suddenly rise, Electrostatic shock, etc.

Remarks: chromaticity and luminance data are measured using photometer Topcon BM-7.

10.0 RELIABILITY SPECIFICATION

10.1 Reliability Test Conditions

No	Test Item	Test Conditions
1	High temperature storage	80°C, 240hrs
2	High temperature operation	70°C, 240hrs
3	Low temperature storage	-30°C, 240hrs
4	Low temperature operation	-20°C, 240hrs
5	High temperature humidity operation	40°C, 90%RH, 240hrs
6	Temperature shock storage	$-30\pm2^{\circ}$ C(30min) ~ 25°C(5min) ~ 80 $\pm2^{\circ}$ C(30min), 10 cycles.
7	Vibration Test((on packaging)	Frequency:10-55Hz , Amplitude:0.75mm , x,y,z every direction for 0.5 hour
8	Drop test (on packaging)	Drop to the ground from 80cm height, 6 side of carton, each once

Remarks:

- 1) For operation test, above specification is applicable when test pattern is changing during entire operation test.
- 2) Inspections after reliability tests are performed when the display temperature resumes back to room temperature.
- 3) It is a normal characteristic that some display abnormality can be seen during reliability test. If the display abnormality can recover as normal condition within 24 hours at room temperature, there is no permanent destruction over the display. The display still possesses its functionality and considered as acceptable after reliability tests.

10.2 Failure Judgment Criteria

After the reliability tests above, test sample shall be let return to room temperature and humidity for at least 4 hours before final tests are carried out.

Item	Acceptance Criteria					
Electrical characteristic	No electrical short and open.					
Liectrical characteristic	Increase in current consumption is less than 2 times of initial value.					
Mechanical characteristic	Within mechanical and drawing specification					
Optical characteristic	Within appearance standard as specified in this specification. Contrast ratio change & ON-transmission value shall not less than 50% of initial value.					

11.0 QUALITY SPECIFICATION

11.1 Acceptable Quality Level (AQL)

Each lot should satisfy the quality level defined as follows:

- a) Inspection method: MIL-STD-105E Level II normal one time sampling
- b) AQL level

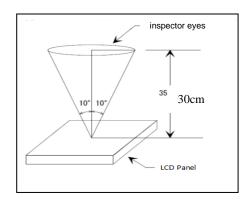
Category	AQL	Definition
Major	0.25%	Functional defective as product
Minor	0.25%	Satisfy all functions as product but not satisfy cosmetic standard

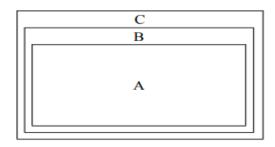
11.2 Conditions of Inspection

- a) Inspection illumination: Function illumination<150Lux; Appearance illumination is 2500 ± 500 Lux.
- b) Inspection distance: About 30cm between the observer's eyes and the LCD.
- c) Inspection angle: Normal inspection angle is $\pm 10^{\circ}$ form LCD.

(Ghost shadow inspection angle is $\pm -45^{\circ}$; Light leakage inspection angle is $\pm -30^{\circ}$)

d) Inspection environment: normal temperature ($18 \sim 27^{\circ}$ C) and normal humidity ($50 \sim 85^{\circ}$ RH)





A: viewing area

B: viewing area except A

C: Outside viewing area

Note: As a general rule, visual defects in C is permissible, when it is no trouble for quality and assembly of customer's product.

11.3 Acceptance Criteria (Display Elektronik GmbH internal standard: IS-QC- 089(E)TFT-1)

a) Function Inspection

Item	Acceptance/Rejection Criteria Clark				Classificatio n	Method	Method	
Functional	2.Obvious color deviat 3.0 Obvious color devi is acceptable; Judgeme filter paper in 1-2 cm d 3.1The standard of ey move the eye sight av inspection time for spo 4.Current consumption 5.Display character/ pa	ation in the same screer int Methods: The distan- istance away from the e e Sight for Spot, Mura way from the filter pap t, Mura:5 seconds. (Idd MAX) shall not ex- titern shall be referred to	the screen is not acceptable, is not acceptable. (spots ce from the panel to ND by position, using monocubad: put the filter paper er and turn the sight backceed the limit specified of	mura which cannot ifilter paper: 350-400 ular observation) in the position in accck to the filter paper	be seen by ND6 % - mm , put the ND cordance with 3.0, . The standard of	Major	Visual (Scale magnifying glass) Visual (Scale magnifying glass)	A
Spot Foreign Particle, Dirt under POL or TP	Length D=(Length-	Width	Zone Size(mm) $D \le 0.15$ $0.15 < D \le 0.2$ $D > 0.2$	Acc Unlin 3	nited	Major	(Scale magnifying	A、B、 C
Line defect:	w	Defect Foreign body . Pit	Size(mm) W≤0.02 0.02 < W≤0.05 and L≤4.0 W≥0.05 W≤0.02	Acc A、B Unlimited 2 (distance ≥ 5mm) Define as s Unlimited	C Unlimited		Visual	
foreign or Scratch		Polarizer fibrous foreign body BL fibrous foreign body	0.02 < W≤0.05 and L≤4.0 W≥0.05 W≤0.02 0.02 < W≤0.05 and L≤4.0	2 (distance ≥ 5mm) Define as s Unlimited 2 (distance ≥ 5mm)	Unlimited	Minor		A. B. C
Polarizer Air or TP film bubble	N/A	A	W≥0.05 Size(mm) D≤0.15 0.15 < D≤0.2 0.2 < D≤0.25	A B Unlimited 3	•	Minor	(Scale magnifying	A、B、 C

Item		Acceptan	ce/Rejection Criter	ia	Classificatio n	Method	Method
			D>0.25	0			
Light dot Dark dot Definition	2). Dot definition: Do 3). Light / Dark dot de Light dot appears in da Dark dot appears in R\	G\B color picture or the wh	een or Blue) or off when the func	或	Minor	Visual (Scale magnifying glass)	A
	1. If the	Defect	Acc No.	Remark		Visual	
	bright/dark dot	light dot	3	0		(Scale magnifying	
	size is less than 1/2 size of sub- pixel, ignore the dot.	light dot two- connection	1	vertical and diagonal connetion are not allowed		glass) See the judgement	
	2. If the	dark dot	3	1		method as below	
	bright/dark dot size is equal or	dark dot two- connection	1	vertical and diagonal connetion are not allowed		350~400mm 双眼	
	more than 1/2 size of sub-pixel, follow the acceptable	dark dot three- connection	3	1		NDigite	
Bright dot/dark dot	number of dot defect specified in the table on the right. 3.Bright dot can not be seen by ND 5% shall follow the tiny bright dot inspection standard. 4.Bright dot/dark dot can be seen by ND5% press	Total	≤3	a two-connection dot count as 2 dots.	Minor	1.0 ND filter paper judgement method for bright dot and tiny bright dot: Distance from the ND filter paper to panel: 1-2 cm position, binocular observation 2.0The standard of eye-sight inspection for Bright dot and tiny Bright dot: put the filter paper in the position in accordance with 1.0, move the eye-sight away from the filter paper and then turn the sight back to the filter	Α
Tiny Bright dot	Tiny bright dot judg	gement, annot be seen with ND6% an be seen with ND6%, t	6, the acceptable	Number is unlimited.			
Distance , Defect number	Distance * 1 Distance between two detects must be more that	ıan 5 mm. *2.Total ı	number of defects ≤3.	Minor	paper. The standard of inspection time for Light spot, Light spot 5 seconds. Visual (Scale magnifying glass)	A	

b) Appearance Inspection

Item	Acceptance/Rejection Criteria				Classificat ion	Method	Method
	A.General chip-out	x (mm)	y (mm)	z (mm)			
		≤4.0	Outside 1/3	Ignore			
Chip-out		S: Innerborder line of the seal			Minor	Visual (Scale magnifying glass)	Out of A
	S 對边團內沿→						

Item	Acc	eptance/Rejection Cr	iteria	Classificat ion	Method	Method	
	B. Chip-out on the back of						
	terminal ledge	x (mm)	y (mm)	z (mm)			
	722		y (mm) ≤0. 3	≤1/2t			
		Ignore ≤4.0	≤0.3 ≤1/4L	≪1/2t ≪t			
			1 - 7				
	C. Chip-out on the terminal ledge but not exactly on the ITO						
	electrode.	x (mm)	y (mm)	z (mm)			
		Ignore	≤0.3	≤1/2t			
		≤4.0	≤1/4L	≤t			
	D. Chip-out on ITO electrode	x (mm)	y (mm)	z (mm)			
			y (mm) ≤0. 3	≤1/2t			
		Ignore ≤2. 0	<0.3 ≤0.8	≤1/2t ≤1/2t			
ı	17	≪3.0	≤0.5	≤t			
	E. Chip-out at corner	x (mm)	y (mm)	z (mm)			
		≤3.0	≤3.0 or ≤1/4L (whichever is less)	≤T	-		
	F. Chip-out at corner	x (mm)	y (mm)	z (mm)	_	Visual	
		3.0	≤3.0	≤T	Minor	(Scale magnifying glass)	Out of A
	, v	Remark: L= cor thickness galss	ntact pad length, T	=Single			
	G. Bur	x (mm)	y (mm)	z (mm)			
	Y	unlimited	≤0.2	≤t			
	H. Crack line				Majoy	Visual	Out of A
Foreign		Zone	Acc	No.			
material \ Black	Width	Size	A, B	C	_	Visual	
dot、		D≤0.15	Unlimited		Minor	(Scale	A
White dot \	Length	0.15 <d≤0.2< td=""><td>3</td><td>Unlimit</td><td></td><td>magnifying glass)</td><td></td></d≤0.2<>	3	Unlimit		magnifying glass)	
Pit Dent Bubble etc.	D=(Length+Width)/2	D>0.2	0	ed		Ŭ	
	Defec		Acc	No.			
		Size (mm)	A, B	С			
Foreign	W Foreig body		Unlimited		Minor	Visual	
material Subble etc.	Pits Polariz r fibro foreig	$\begin{array}{c c} us & W \leq 0.05 \text{ and} \\ n & L \leq 4.0 \end{array}$	2 (distance \geq 5mm)	Unlimit ed		(Scale magnifying glass)	A
	body	W≥0.05	Define as	spot defect			

Item	Acce	ptance/Rejection Cri	teria		Classificat ion	Method	Method
bubble or TP film			A, B	С		(Scale	С
bubble		D≤0.15	Unlimited				
		0.15 < D≤0.2	3	I I to live in a st		giass)	
		0.2 < D≤0.25	1	Unlimited			
		D > 0.25	0				
Distance	Distance between two detects must	be more than 5 mm.			Minor	magnifying	A
LC bubble	Not acceptable.				Minor	magnifying	A
Polarizer	_	izer dimension & position shall meet the requirement indicated on the drawing. izer orientation shall meet the requirement indicated on the drawing. (Background nall be consistent with the sample).					Out of A
Protective film	1.Protective film separating in Acti 2.Fingerprint\ Massive dirt in the p	Minor	magnifying	All			
FPC cosmetic defect	3.Erasable smudginess must be clear According to IPC-6013A.	aned, unerasable smud	lginess is allowed	l	-	_	-
RTV (Tuffy)	1.Coating location shall meet the mover all terminal tracks. 2.RTV pin holes and bubble shall material shall not case. 4.Uncured coating is not acceptable of the shall material shall not case. 5.RTV Coating cannot be damaged of the shall not exceed the over to the polarizer or the interfact. 7.Massive dirt on the coating is not shall not exceed the over to the polarizer or the interfact.	not cause ITO tracks e ause ITO short-circuit e. I. (Include irregular de height of the polarize e components.	xposed.		Majoy	Visual	Out of A
	Backlight unit dimension and for	rm shall meet the requ	irement on the dr	awing.	Majoy	caliper	Out of A
BLU	2.Backlight not light up, or wrong and acceptable. (Refer to the limit statement of the LCD not acceptable.) 5.Light leak is not acceptable in manapplicable. 6. LCD shall not be lifted after asset acceptable in the limit statement.	c., bright spot, and scra CD.4. Uneven brightne (ample if applicable). (ain viewing direction.	tch mark shall ref ss in the Viewing	Area Zone A is	Minor	Visual	Out of A
	7.Backlight reflecting film can't sep						
Label Printing						Visual	Out of A
The	1.The outer dimension shall meet the	he specification the dr	awing.		Major	caliper	Out of A
product shall be free of dirt.	2.The product shall be free of dirt.				Minor	Visual	Out of A

12.0 ENVIRONMENTAL SPECIFICATION

This product is designed, manufactured and compliant to below RoHS standard:

1. Cadmium and Cadmium Compounds

2. Hexavalent Chromium Compounds

3. Lead and Lead Compounds

4. Mercury and Mercury Compounds

Less than 100ppm

Less than 1000ppm

Less than 1000ppm

Less than 1000ppm

- 5. Polybrominated Biphenyls (PBBs)
- 6. Polybrominated Diphenyl ethers (PBDEs)
- 7. Butyl benzyl phthalate (BBP)
- 8. Bis (2-ethylhexyl)phthalate (DEHP)
- 9. Dibutyl phthalate (DBP)
- 10. Diisobutyl phthalate(DIBP)

Less than 1000ppm Less than 1000ppm

13.0 GENERAL PRECAUTIONS FOR USING LCD MODULES

Handling Precaution

- No strong mechanical shock. LCD may be broken because it is made out of glass.
- Do not work on PCB. PCB may be cracked or damaged.
- Do not bend or process metal bezel positioning tab.
 LCD maybe shifted and LCD-PCB interconnection may be damaged,
- Do not scratch. Polarizer is soft material and can be easily scratched.
- Liquid crystal may leak when LCD/LCM is broken.
 Please wash your hands if you touch the liquid crystal.
- Wear gloves when handling LCD/LCM to avoid damage to LCD/LCM. Please do not touch electrodes with bare hands to avoid any contamination on connection.

Soldering Precaution on LCD/LCM

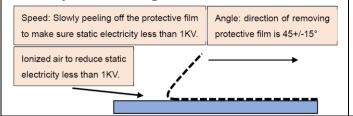
- Use soldering iron with proper grounding and no AC leakage.
- Temperature at tip of soldering iron: 330±10°C
- Type of solder: lead-free solder with resin flux fill.
- Soldering time: < 3sec.
- Soldering on LCD/LCM I/O terminal only.
- Do not apply force on the LCD metal pin when soldering. Metal pin connection to LCD terminal will be damaged or loosen by this external force under soldering temperature.
- Do not solder and de-solder for more than 3 times because metal pin connection or soldering pads will be damaged.

Operation Precautions

- Viewing angle can be adjusted by varying driving voltage, V₀ or Vop.
- Display performance may vary or show abnormal electro-optical performance when viewed at angle beyond the specified viewing angle range.
- Display color may change under extreme temperature. This is not destructive symptom and display color will resume back to normal when temperature goes back to normal temperature.
- Driving voltage shall be kept within the specified range as stated in this product specification. Overvoltage may shorten the LCD/LCM lifetime.
- No DC voltage to LCD/LCM. Electrical characteristics and reliability of LCD/LCM will deteriorate under DC.
 Please control the DC content in application driving circuit.
- Avoid using the same display pattern for long time (continuous ON segment). It is a normal phenomena observed for passive driven display where image retention is observed when LCD is displayed with same pattern over 1 hour under temperature > 55°C. Customer is advised to design application software where display pattern will be changed from time to time, or using the N-line inversion function comes with the display driver IC.
- If the LCM is using master-slave configuration, customer is strongly recommended to use external Vo.
- If the LCM comes with MTP/OTP function, customer is recommended to use this MTP/OTP function for the best optical performance.

Static Electricity FPC cleanness

- Avoid static electricity. Please have proper ESD control and ground the human body and any electrical tools when assembling the LCD/LCM.
- Static electricity will be generated when peeling the protective film. It is a normal behavior that LCD/LCM will response to the static charges generated and will resume back to normal condition slowly. Peeling off the protective film in a correct way is very important to reduce the static electricity and its influence on LCD/LCM. It's recommended that the static electricity is controlled less than 1KV by using ion fan and peeling off protective film slowly and in 45° angle, etc.



If ACF bonding is applied at customer side between FPC and PCB, cleaning on FPC and PCB bonding area (just before bonding) is a must to reduce risk of bonding reliability (eg bonding delamination/spring back phenomenon, low pull strength etc)

Long-term Storage Conditions

- Store LCD/LCM in dark area and keep LCD/LCM away from direct sunlight and fluorescent light.
- Store LCD/LCM under temperature range of 0~35°C and room humidity of 50~60%RH.
- Possible Vop adjustment might be needed at customer side after prolong storage over 1 year from date of manufacturing.

14.0 APPENDIX

14.1 Functional testing pattern

Below test patterns will be used at all LCM functional tests at mass production stage. Acceptance of a product during inspection will be judged based on these test patterns only. Customer should notify Display Elektronik GmbH if different test patterns being used at customer side to ensure same testing platform between Customer and Display Elektronik GmbH, especially on those defects (flickering, image sticking, cross-talk, black/white line) which are pattern-dependent. These test patterns are by default agreed by both Customer and Display Elektronik GmbH, unless notified by Customer to revise such test patterns. If the defect listed in above description is seen in below pattern, LCD module should be judged as NG and vice versa.





3) Black pattern:



5) Red pattern:







6) Green pattern:

